Search Notes

_	Application/Control No.	Applicant(s)/Patent under Reexamination		
	10/595,540	SHINDO, HIDE	IIRO	
	Examiner	Art Unit		
	Hien D. Vu	2833		

SEARCHED						
Subclass	Date	Examiner				
497 499 495 579 607 610	6/12/07					
	\$497 \$499 \$495 \$190	Subclass Date 497 6/12/07 499 495 607				

INTERFERENCE SEARCHED					
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